

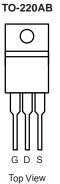
### N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>			
60	0.024 at V <sub>GS</sub> = 10 V	50			
	0.028 at V <sub>GS</sub> = 4.5 V	40			

### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC







S N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	60	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	V	
Continuous Drain Current <sup>f</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	1_	50	А	
Continuous Drain Current	VGS at 10 V	T <sub>C</sub> = 100 °C	ID	36		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200	]	
Linear Derating Factor				1.0	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>	1	0.025				
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	Р	150	W	
Maximum Power Dissipation (PCB Mount) <sup>e</sup>	T <sub>A</sub> =	25 °C	P <sub>D</sub> –	3.7		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub> - 55 to + 175		°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for	10 s		300 <sup>d</sup>		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ ,  $L = 179 \text{ }\mu\text{H}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 51 \text{ A}$ , dl/dt  $\le 250 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

d. 1.6 mm from case.

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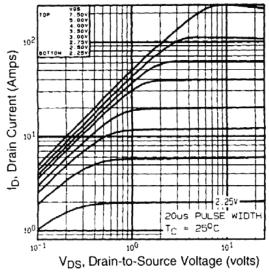
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PARAMETER	SYMBOL	ТҮР		MAX.			UNIT		
Maximum Junction-to-Ambient				62		UNIT			
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub> R <sub>thJA</sub>	-		40		°C/W			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 1.0				-			
ote When mounted on 1" square PCB (FR-4	or G-10 material)	•							
<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , u		I			1			1	
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNI	
Static		1			r	1			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 25	50 μA	60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 1 \text{ mA}$		-	0.070	-	V/°C		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		1.0	-	2.5			
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 10 \text{ V}$		V	-	-	± 100	nA	
Zaus Oats Visitaas Dusis Ouwant		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	μA	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 48 V,	$V_{\rm DS} = 48 \text{ V}, \text{ V}_{\rm GS} = 0 \text{ V}, \text{ T}_{\rm J} = 150 \text{ °C}$			-	250		
	-	V <sub>GS</sub> = 10 V	۱ <sub>D</sub>	= 21 A <sup>b</sup>	-	0.024	-	1	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V	١ <sub>D</sub>	= 15 A <sup>b</sup>	-	0.028	-	Ω	
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 21A <sup>b</sup>		23	-	-	S		
Dynamic					I				
Input Capacitance	C <sub>iss</sub>					190			
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	920	-	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>			_	170	-			
Total Gate Charge	Qg	V <sub>GS</sub> = 5.0 V $I_D = 51 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and $13^{\text{b}}$			-	-	66	<u> </u>	
Gate-Source Charge	Q <sub>gs</sub>			_	_	12	nC		
Gate-Drain Charge	Q <sub>gd</sub>			_	_	43			
Turn-On Delay Time	t <sub>d(on)</sub>			_	17	-			
Rise Time	t <sub>r</sub>	.,	00.1/			230	_		
Turn-Off Delay Time		$ V_{DD} = 30 \text{ V, } I_D = 51 \text{ A,} \\ R_g = 4.6 \Omega, R_D = 0.56 \Omega, \text{ see fig. } 10^{\text{b}} \\ -$		_	200	_	ns		
Fall Time	t <sub>d(off)</sub> t <sub>f</sub>			, C	_	110	_	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	_	nH		
Internal Source Inductance	LS			-	7.5	-			
Drain-Source Body Diode Characteristic	cs				1				
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 <sup>c</sup>	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	200			
Body Diode Voltage	V <sub>SD</sub>	$T_{J} = 25 \text{ °C}, I_{S} = 51 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C}, I_{F} = 51 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^{b}$ Intrinsic turn-on time is negligible (turn-		-	130	180	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC		
Forward Turn-On Time	t <sub>on</sub>			-on is dor	ninated b	v L - and	L_)		

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



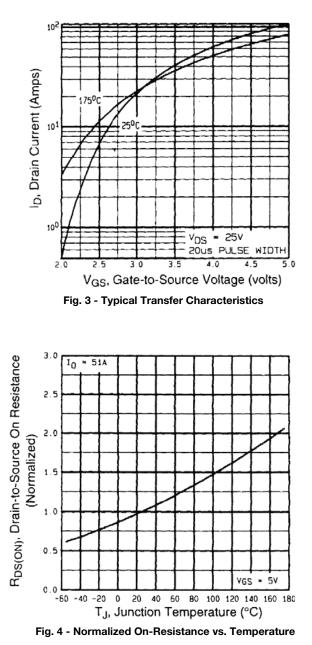


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C





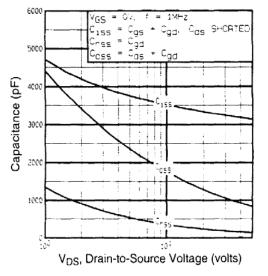


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

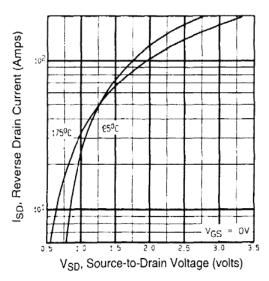
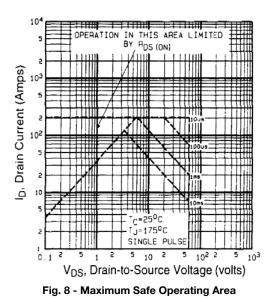


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





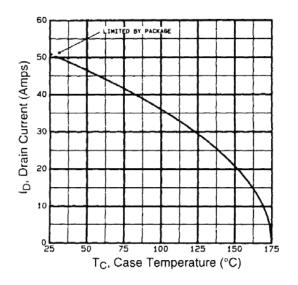


Fig. 9 - Maximum Drain Current vs. Case Temperature

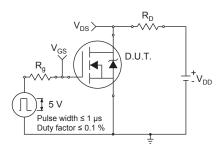


Fig. 10a - Switching Time Test Circuit

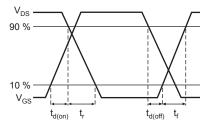
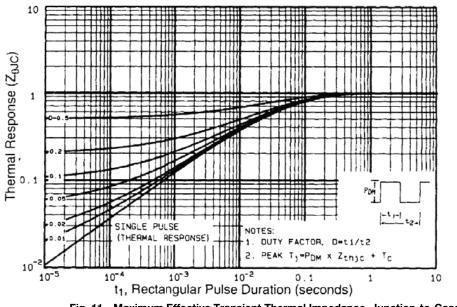


Fig. 10b - Switching Time Waveforms







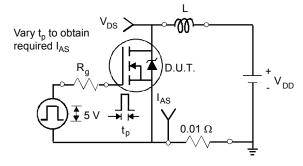


Fig. 12a - Unclamped Inductive Test Circuit

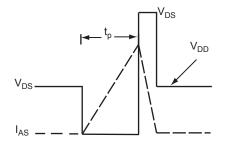


Fig. 12b - Unclamped Inductive Waveforms

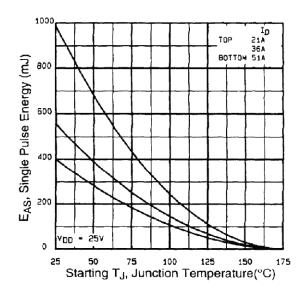


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

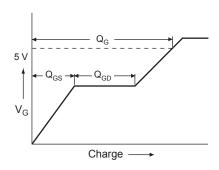


Fig. 13a - Basic Gate Charge Waveform

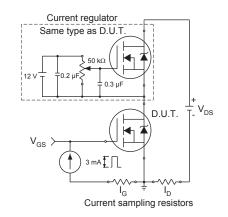
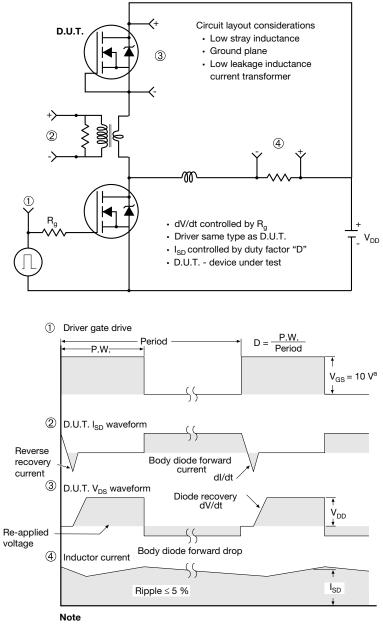


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

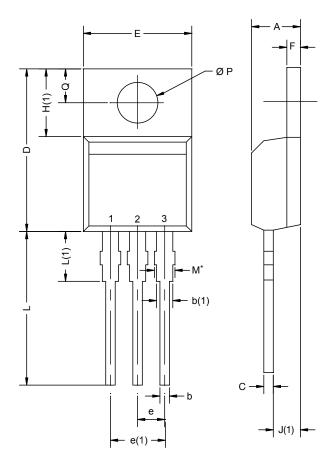


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØР	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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